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Intrabeam Scattering Results for a High Frequency RF System

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Intrabeam Scattering Results for a
High Frequency RF System

 $({\it Mini-Workshop\ on\ RHIC\ RF\ Systems})$

July 11-15, 1988 Collider Center

> G. Parzen BNL

Intra beam Scattering Results

High Frequency RF System

G. Parzen 7/6/88

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Factors Leading to Growth

Invarient,
$$\int_{\overline{E}}^{2} - 2 \int_{\overline{\chi}}^{2} = Constant$$

$$\mathcal{D} = \frac{1}{\sigma_{p}} \frac{d\sigma_{p}}{dt} = 2\left(\frac{\sigma_{x}}{\sigma_{E}}\right)^{2} \frac{1}{\sigma_{x}} \frac{d\sigma_{x}}{dt}$$

If $\Gamma_{E} < C_{x}$ at=>, then Γ_{E} will grow much faster than Γ_{x} until $\Gamma_{E} \sim 1.4 \, G_{x}$

 $\frac{\mathcal{E}}{\mathcal{E}}$ $\frac{\mathcal{E}}{\mathcal{E}$

Protons may show large growth in DE,

 $\frac{1}{\sigma_{x}} \frac{d\sigma_{x}}{dt} \simeq \frac{\sigma_{E}^{2}}{\sigma_{E}^{2} + \sigma_{x}^{2}}$ $\frac{1}{\sigma_{p}} \frac{d\sigma_{p}}{dt} \simeq 2 \frac{\sigma_{x}^{2}}{\sigma_{E}^{2} + \sigma_{x}^{2}}$

A STATE OF THE STA

. High Frequency RF system
To get shorter of suggests f~200 MHz
New Suggested Procedure
Varied with time sother bucket
gust Contains the bunch DB = 2 0p
at all times.
For fixed op/DB, of is constant.
$\overline{J_{e}} = \sin \frac{1}{2}$
B
1 /2 /2
For ΔB = 20P, 9 = 60° = ±11
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Proposed RF System

f = 160 MHz, h = 2052 Te = 31 cm, $A_0 = .3$ eV-sec $\Delta B = 2$ Tp

frequency dependence

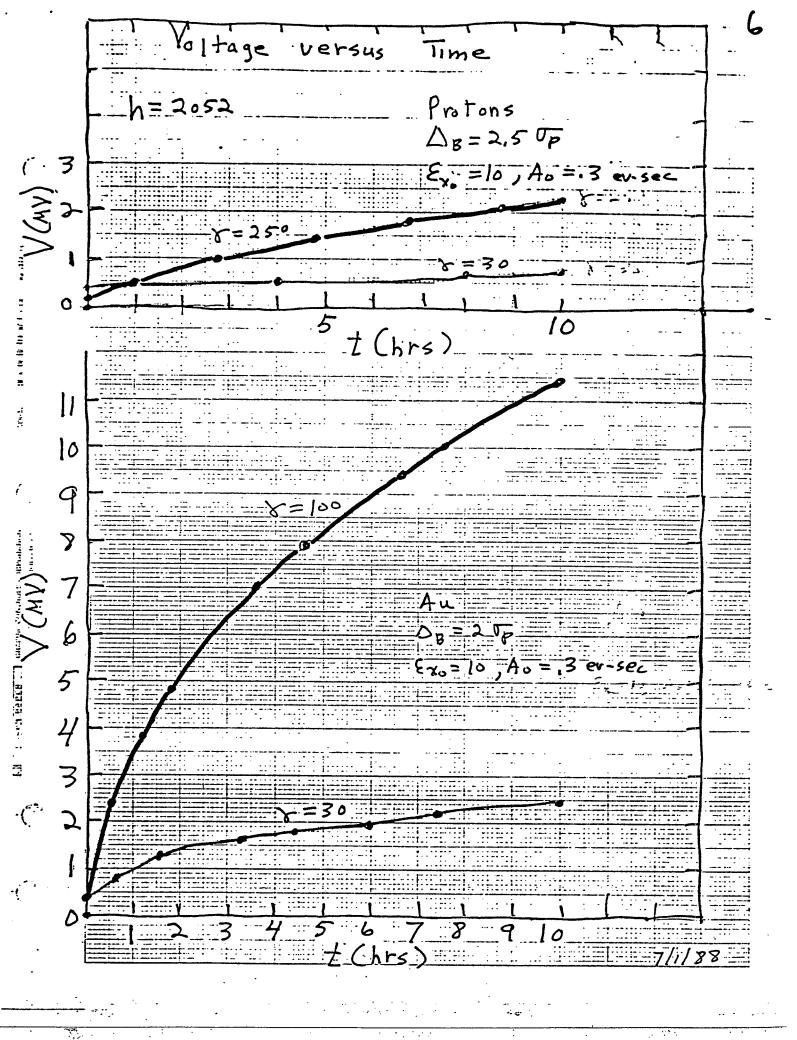
Initially, Te ~ 1/f, Te ~ f, V~f3

For final state > V ~ f 1.54 for one case-

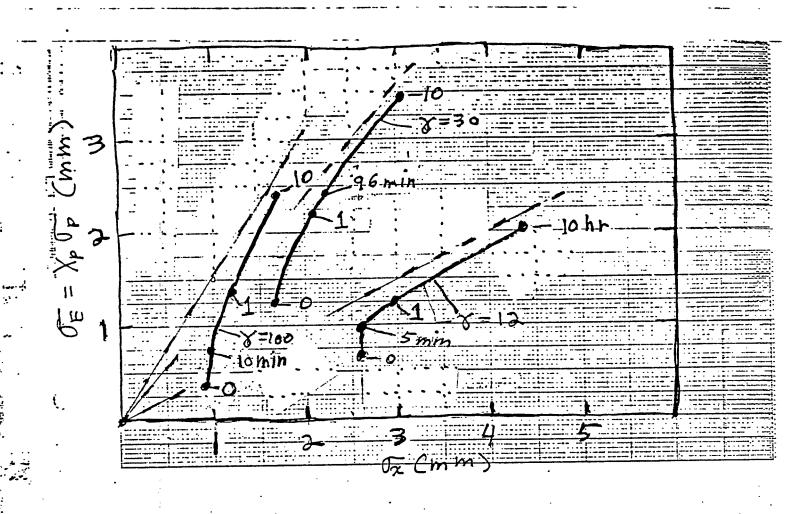
Dependence on $fB = \Delta_B/T_P$

Initially, Je~1/fB, Jp~fB, V~fB

For final state) Y ~ fg 2.6 for one case.



	Dependence on Initial Bunch Area	
13-		
12/	======================================	
1 -		
10		
	V(MY)	
9		
8		
7		
•		
6		
5		
4	8=30	
3		
2		
* 72 4	Y=30 and Y=100 En	
30		
20	1 - 2	
3	Jp/10 = 3000	
・ うへ	γ-100	
7		
1		
	0 .0	
	T+n) Area (eV-sec/	mu) =7/



INTRABEAM SCATTERING ABOVE TRANSITION*

$$\tau_{E}^{-1} = \frac{1}{\delta_{E}} \cdot \frac{d\delta_{E}}{dt} = \left[\frac{\langle \sigma_{H} \rangle}{\langle X_{p} \rangle \delta_{E}}\right]^{2} \tau_{H}^{-1}$$

with

$$\tau_{\mathrm{H}}^{-1} = \frac{27\pi}{2} L_{\mathrm{g}} r_{\mathrm{p}}^{2} E_{\mathrm{o}} \frac{N_{\mathrm{g}}}{S \varepsilon_{\mathrm{H}} \varepsilon_{\mathrm{v}}} \frac{\langle X_{\mathrm{p}} \rangle}{\langle \beta \rangle} \frac{1}{\left[1 + \left(\frac{\langle \sigma_{\mathrm{p}} \rangle}{\langle X_{\mathrm{p}} \rangle \delta_{\mathrm{E}}}\right)^{2}\right]^{1/2}} \left[\frac{Q^{2}}{A}\right]^{2}$$

where

$$L_{g} \approx 20$$

$$r_{p} = \frac{\mu_{o} e^{2}c^{2}}{4\pi E_{o}}$$

$$\langle \sigma_{H} \rangle = \left[\frac{\varepsilon_{H}}{6\pi} \frac{\langle \beta \rangle}{\gamma}\right]^{1/2}$$

$$S = 6\pi \sigma_{\ell} \delta_{E} \gamma E_{0}/c$$

 $\varepsilon_{\rm H,V}$ = normalized transverse emittance

 $\langle \beta \rangle$ = averaged betatron function

^{*}G. Parzen, Nucl. Instr. Meth. <u>A251</u>, p. 220 (1986), <u>A256</u>, p. 231 (1987).